

March 2009

FDS6675BZ

P-Channel PowerTrench® MOSFET

-30V, -11A, 13mΩ

General Description

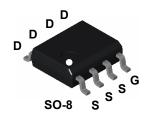
This P-Channel MOSFET is producted using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance.

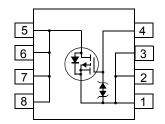
This device is well suited for Power Management and load switching applications common in Notebook Computers and Portable Battery Packs.



Features

- Max $r_{DS(on)} = 13m\Omega$ at $V_{GS} = -10V$, $I_D = -11A$
- Max $r_{DS(on)}$ = 21.8m Ω at V_{GS} = -4.5V, I_D = -9A
- Extended V_{GS} range (-25V) for battery applications
- HBM ESD protection level of 5.4 KV typical (note 3)
- High performance trench technology for extremely low r_{DS(nn)}
- High power and current handing capability
- RoHS Compliant





MOSFET Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter	Ratings	Units	
V_{DS}	Drain to Source Voltage		-30	V
V_{GS}	Gate to Source Voltage		±25	V
ı	Drain Current -Continuous	(Note 1a)	-11	۸
ID	-Pulsed		-55	Α
	Power Dissipation for Single Operation	(Note 1a)	2.5	
P_{D}		(Note 1b)	1.2	W
		(Note 1c)	1.0	
T _J , T _{STG}	Operating and Storage Temperature		-55 to 150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance , Junction to Ambient (Note 1a)	50	°C/W
$R_{\theta JC}$	Thermal Resistance , Junction to Case (Note 1)	25	°C/W

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape Width	Quantity
FDS6675BZ	FDS6675BZ	13"	12mm	2500 units

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Electrical Characteristics T_J = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
B _{VDSS}	Drain to Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-30			V
$\frac{\Delta B_{VDSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = -250 μ A, referenced to 25°C		-20		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -24V, V_{GS} = 0V$			-1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 25V, V_{DS} = 0V$			±10	μΑ

On Characteristics (Note 2)

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = -250 \mu A$	-1	-2	-3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = -250 μ A, referenced to 25°C		15.7		mV/°C
·	V _{GS} = -10V , I _D = -11A		10.8	13.0		
r _{DO(++})	Drain to Source On Resistance	$V_{GS} = -4.5V, I_D = -9A$		17.4	21.8	mΩ
r _{DS(on)} Drain to Source On Resistance	V_{GS} = -10V, I_{D} = -11A T_{J} = 125°C		15.0	18.8	11122	
g _{FS}	Forward Transconductance	$V_{DS} = -5V$, $I_{D} = -11A$		34		S

Dynamic Characteristics

C _{iss}	Input Capacitance	\\ - 45\\\\ - 0\\	1855	2470	pF
Coss	Output Capacitance	V _{DS} = -15V, V _{GS} = 0V, f = 1MHz	335	450	pF
C _{rss}	Reverse Transfer Capacitance	111112	330	500	pF

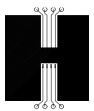
Switching Characteristics (Note 2)

t _{d(on)}	Turn-On Delay Time			3.0	10	ns
t _r	Rise Time	V_{DD} = -15V, I_{D} = -11A V_{GS} = -10V, R_{GS} = 6 Ω		7.8	16	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = -10V, R_{GS} = 6\Omega$		120	200	ns
t _f	Fall Time			60	100	ns
Qg	Total Gate Charge	$V_{DS} = -15V, V_{GS} = -10V,$ $I_{D} = -11A$		44	62	nC
Q_g	Total Gate Charge	1, 45)(1)(5)(25	35	nC
Q_{gs}	Gate to Source Gate Charge	$V_{DS} = -15V, V_{GS} = -5V,$ $I_{D} = -11A$		7.2		nC
Q_{gd}	Gate to Drain Charge	ID = -11A		11.4		nC

Drain-Source Diode Characteristics

V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_S = -2.1A$	-0.7	-1.2	V
t _{rr}	Reverse Recovery Time	$I_F = -11A$, di/dt = 100A/ μ s		42	ns
Q _{rr}	Reverse Recovery Charge	I _F = -11A, di/dt = 100A/μs		30	nC

1: R_{BJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{BJC} is guaranteed by design while R_{BCA} is determined by the user's board design.



a) 50°C/W when mounted on a 1 in² pad of 2 oz copper



b)105°C/W when mounted on a .04 in² pad of 2 oz copper



c) 125°C/W when mounted on a minimun pad

- Scale 1:1 on letter size paper
- 2: Pulse Test:Pulse Width <300 us, Duty Cycle < 2.0%
- 3: The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

Typical Characteristics T_J = 25°C unless otherwise noted

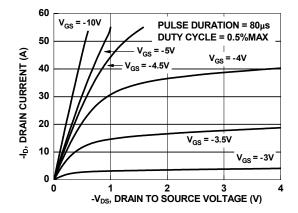


Figure 1. On Region Characteristics

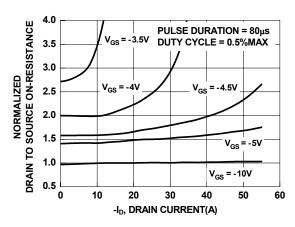


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

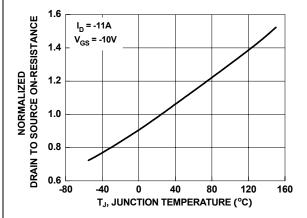


Figure 3. Normalized On Resistance vs Junction Temperature

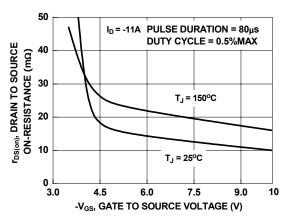


Figure 4. On-Resistance vs Gate to Source Voltage

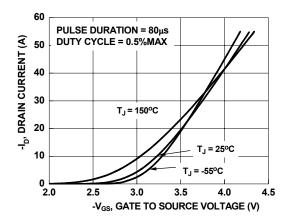


Figure 5. Transfer Characteristics

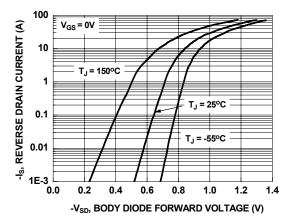
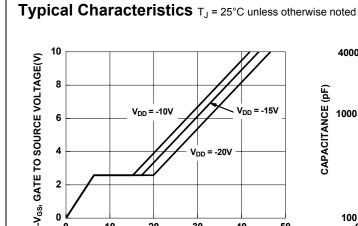


Figure 6. Source to Drain Diode Forward Voltage vs Source Current



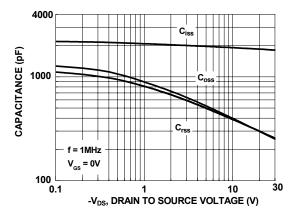


Figure 7. Gate Charge Characteristics

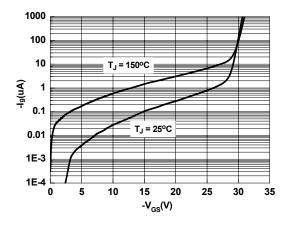
Qg, GATE CHARGE(nC)

40

50

10

Figure 8. Capacitance vs Drain to Source Voltage



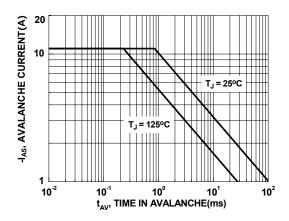
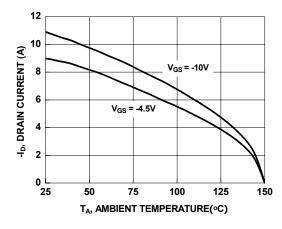


Figure 9. I_g vs V_{GS}

Figure 10. Unclamped Inductive Switching Capability



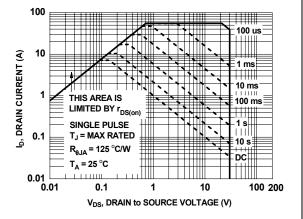


Figure 11. Maximum Continuous Drain Current vs **Ambient Temperature**

Figure 12. Forward Bias Safe Operating Area



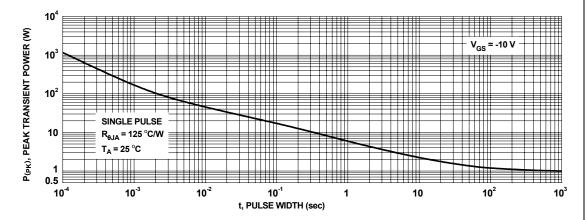


Figure 13. Single Pulse Maximum Power Dissipation

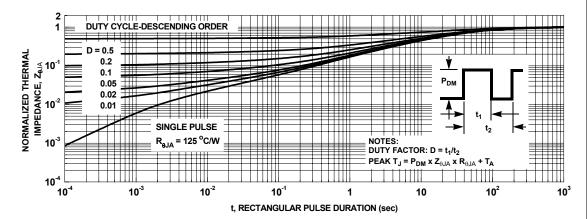


Figure 14. Junction-to-Ambient Transient Thermal Response Curve





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